Differential Probes

Measure two
voltage points in
a circuit and
provide, as an
output, the
difference
between two
voltages.

Avoid ground loop errors in mixed signal circuits.

Test twisted pair data links.

P6046

- Active Differential System
- DC to 100 MHz
- 1X/10X Differential
- Typically 10,000:1 CMRR Derating to 1,000:1 at 50 MHz
- ±250 V Maximum Voltage with 10X Attenuator

Differential Measurements

Differential measurement systems enable you to simultaneously measure two voltage points in a circuit and provide as an output the difference between the two voltages.

Tektronix offers two types of differential measurement probes: the active differential probe system and the passive matched pair of probes. The P6046 and P5200 are active differential amplifiers in probe form which connect to one channel of a standard scope amplifier. The P6135A and P5135 are passive probe pairs designed to enhance the performance of a differential amplifier.



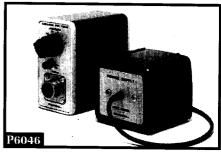
P6046 with 10X Attenuator

P6046 ACTIVE DIFFERENTIAL PROBE SYSTEM

The P6046 is a self-contained active differential system consisting of a Differential Probe, Amplifier and Power Supply. Active FET amplifiers at the dual-inputs reduce circuit loading. Combined with the differential processing occurring in the probe head, the P6046 provides superior common mode rejection ratios (CMRR) at high frequencies typically 10,000:1 out to 50 kHz, derating to 5,000:1 at 1 MHz.

Since the P6046 is self-contained, it provides a differential output into a single channel of any oscilloscope. System controls enable you to select AC or DC coupling, adjust the DC balance and select mV/div from 1 to 200 mV (10 mV to 2 V with attenuator head) in standard 1, 2, 5 steps.

A slip-on 10X attenuator is also included which increases the maximum input voltage from ± 25 V to ± 250 V and the common mode dynamic range from ± 5 V to ± 50 V.



P6046 Amplifier with Power Supply

Characteristics

CMRR – With deflection factors of 1 to 20 mV/div: at least 10,000:1 at 50 kHz, 5,000:1 at 1 MHz, and 1,000:1 at 50 MHz (DC coupled).

Common Mode Linear Dynamic Range – ±5 V, ±50 V with 10X attenuator.

Bandwidth - DC to 100 MHz (-3 dB).

Rise Time - 3.5 ns or less.

Deflection Factor Range – 1 to 200 mV/div in eight calibrated steps, 1-2-5 sequence, accurate within 3% (with an oscilloscope deflection factor of 10 mV/div). Input RC 1 M Ω paralleled by 10 pF or less.

Input Coupling – AC or DC, selected by a switch on the probe. Low frequency response AC-coupled is –3 dB at 20 Hz, 2 Hz with 10X attenuator

Displayed Noise – Typically 450 mV or less (tangentially measured).

Maximum Input Voltage $-\pm 25$ V (DC + peak AC), ± 250 V with 10X attenuation, derated with frequency. The P6046 circuitry can be damaged by electrostatic discharge. Please refer to the manual for use.

Output Impedance $-50~\Omega$ through a BNC-connector. $50~\Omega$ termination supplied with amplifier for use with 1 M Ω systems.

Probe Cable – 6 ft. long, terminated with special nine-pin connector.

APPLICATIONS

Power Supplies
 Intell

ORDERING INFORMATION

- Disk Drives
- Electronic Ballast

- Intelligent Motion
- Single and Three Phase Adjustable Speed Drives

Product(s) available through your local Tektronix representative (listed in the back of this catalog) or call 1-800-426-2200.

P6046



Tektronix Measurement
products are manufactured in
ISO poletaned building

Instruction Manual (070-7129-01).

Opt. A6 – Japan, 100 V, 50 Hz	NC
Power Supply with Amplifier - Order 015-0106-00	\$1,515
SERVICE ASSURANCE OPTIONS	
Opt. R2 – Adds two years of post-warranty	
Repair Protection	+\$100
Opt. C5 - Adds five years of Calibration Services	+\$325